





# Scanbot: An STM Automation Bot

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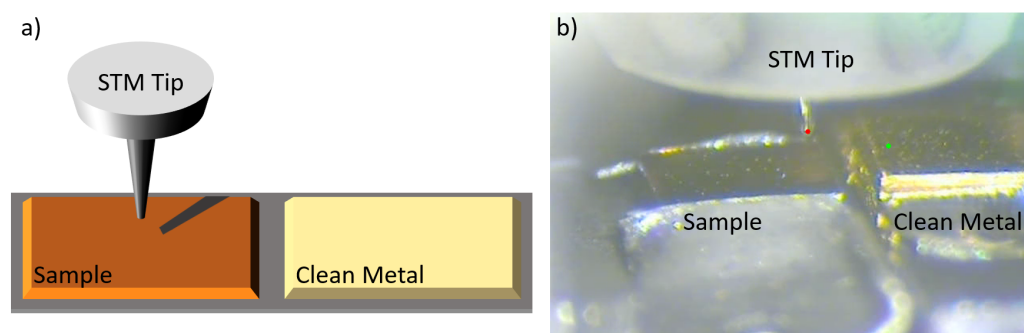
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## Summary

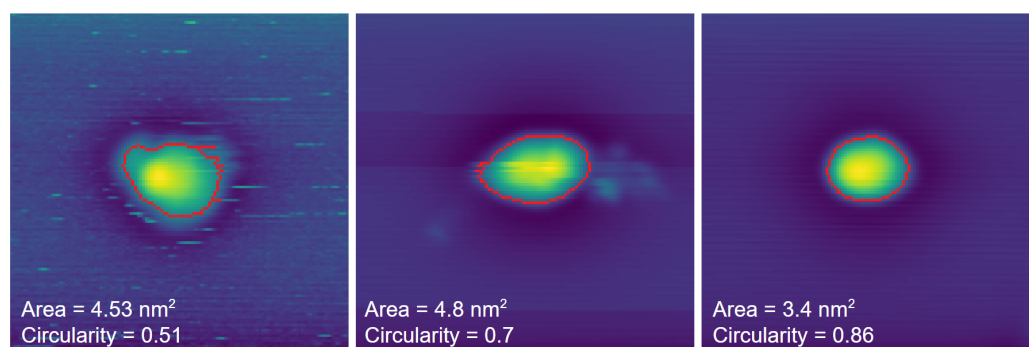
Scanning Tunnelling Microscopes (STM) are capable of capturing images of surfaces with atomic-scale resolution. This is achieved by scanning an atomically sharp probe across the surface of the sample while monitoring an electric current. However, the quality of STM data relies heavily on the atomic-scale geometry and composition of the scanning probe apex, as well as the roughness and cleanliness of the scanned region. For instance, blunt tips result in blurry images while contaminated tips can lead to noisy images due to interactions with the sample. As a result, optimal STM data acquisition commonly requires time-consuming tasks such as probe conditioning—i.e., sharpening via “tip-shaping”, where the apex of the probe can be refined by poking it into a clean metal surface—and identification of areas of interest of the sample. Moreover, the quality of the probe can vary during a scan, especially when scanning over debris or excessively rough areas, necessitating additional tip-shaping.

Here, we present Scanbot, a program that fully automates common STM data acquisition techniques, as well as tip-shaping and sample surveying. Scanbot relies on a dual sample holder (DSH; [Figure 1](#)), where a sample of interest is mounted alongside a clean reference metal surface, which is ideal for tip preparation. Scanbot is able to analyse STM images and identify when the probe requires conditioning, subsequently moving it from the sample of interest to the clean reference metal, where it will prepare a scanning probe capable of obtaining high-quality STM images. This is accomplished using built-in piezoceramic scanners to maneuver the STM tip while tracking its position through a camera feed; [Figure 1b](#)). Once Scanbot determines that the probe has been conditioned adequately, it moves the tip back to the sample of interest and STM data acquisition resumes.



**Figure 1:** Tracking and maneuvering the STM probe above the dual sample holder (DSH). **a)** Schematic of the STM tip over the dual sample holder setup. A sample of interest is mounted next to a clean reference metal substrate (e.g. Au(111)) which is ideal for tip shaping. **b)** Image from the camera feed used by Scanbot to track and maneuver the STM probe automatically from the sample to the clean reference metal, where it can be refined. The red (green) marker indicates the probe apex position (target position, respectively). See Scanbot [documentation](#) for a video example.

**Figure 2** demonstrates Scanbot's ability to recondition a 'bad' tip on a clean reference metal surface. Scanbot can gently impinge the scanning probe apex onto a clean, flat region of the metal surface, which results in an imprint associated with the geometry of the tip. This imprint can then be scanned, and the resulting image is similar to the auto-correlation function of the tip's apex. The quality of the tip can be assessed by measuring the area and circularity of the imprint. If the imprint does not meet the desired criteria, a more aggressive tip shaping action is carried out, and the process is repeated until a high-quality tip is achieved.



**Figure 2:** Successive STM images (left to right) of the tip's imprint on a clean metal surface, each following a more aggressive tip-shaping action in a different location. The area and circularity of each imprint reflects the geometry of the apex of the scanning probe. Thus the process is repeated until a desired geometry is achieved.

## Statement of need

To reduce the time-intensive nature of STM experiments, various innovative solutions have been implemented to automate specific tasks. For instance, Wang et al. created a Python package that automates probe conditioning for Scanning Tunneling Spectroscopy (Wang et al., 2021). However, this package still requires manual preparation of the tip such that it can acquire clean images. Some researchers have employed the use of machine learning algorithms to analyse acquired images and determine when a probe needs refining (Gordon et al., 2020; Rashidi & Volkow, 2018), then Reinforcement Learning (RL) agents can condition the probe accordingly (Krull et al., 2020). Although these approaches have significantly advanced automation in STM experiments, they are often tailored to specific surfaces and STM equipment, making

it challenging to transfer them directly to other labs studying different kinds of samples or working with different STM systems.

To overcome these limitations, we have developed Scanbot, a Python robot that is compatible with a broader range of STMs, specifically those compatible with the Nanonis V5 software (Ceddia et al., 2022; Specs-GmBH, 2015). Additionally, our package incorporates Scanbot's distinctive approach to tip shaping, which involves monitoring the tip's motion above a dual sample holder. This method is particularly beneficial in experiments where the sample's properties might make it challenging to achieve a high-quality scanning probe without needing to manually switch out the sample for a clean metal on which the tip can be prepared.

Scanbot has been developed in a modular fashion, which means its functionality can easily be expanded or improved through contributions from the open-source community. Furthermore, through the use of [hooks](#), users can customise or replace key functionalities that are system- or lab-specific, without rewriting Scanbot's source code. This has the advantage of being able to update Scanbot to the latest version without losing customised code. Such hooks can also be used to improve Scanbot's existing functionality or test potential new features. For instance, Scanbot's algorithmic approach to automated tip shaping might benefit the integration of an RL agent. This could be achieved by leveraging the hook [hk\\_tipShape](#), where important parameters related to tip shaping can be adjusted based on images of the tip's imprint. Complete documentation for Scanbot, including how such hooks can be leveraged, can be found at <https://new-horizons-spm.github.io/scanbot>.

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